

Search Notes

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Applicant(s)/Patent under
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Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
708	620-625, 491-492	6/27/2006	MAI

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search Double Patenting Check Data Bases Search (see search history printout)	6/27/2006	MAI